

Japan Specified Radio Test Report

Report No. : 1812C50454812502

Applicant : Anker Japan Co., Ltd.

Address : 9F Waterras Tower, 2-101, Kanda-Awajicho,
Chiyoda-ku, Tokyo

Product Name : eufy Baby Monitor C10

Report Date : 2025-10-30

Shenzhen Anbotek Compliance Laboratory Limited



Shenzhen Anbotek Compliance Laboratory Limited

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Contents

1. General Information	6
1.1. Client Information	6
1.2. Description of Device (EUT)	6
1.3. Auxiliary Equipment Used During Test	7
1.4. Description of Test Configuration	7
1.5. Test Conditions	7
1.6. Test Voltage	8
1.7. Test Equipment List	8
1.8. Description of Test Facility	10
1.9. Disclaimer	10
1.10. Measurement Uncertainty	10
2. Summary of Test Results	11
3. Frequency Tolerance Test	12
3.1. Test Limit	12
3.2. Test Setup	12
3.3. Test Procedure	12
3.4. Test Data	12
4. Antenna Power Test	13
4.1. Test Limit	13
4.2. Test Setup	13
4.3. Test Configuration	13
4.4. Test Data	13
5. Occupied Bandwidth (99%) Test	14
5.1. Test Limit	14
5.2. Test Setup	14
5.3. Test Procedure	14
5.4. Test Data	14
6. Spurious Emissions Intensity Test	15
6.1. Test Limit	15
6.2. Test Setup	15
6.3. Test Procedure	15
6.4. Test Data	15
7. Carrier Sensing Function 2	16
7.1. Test Limit	16
7.2. Test Setup	16
7.3. Test Configuration	16
7.4. Test Data	16
8. Interference Prevention Function	17
8.1. Test Limit	17
8.2. Test Setup	17



8.3. Test Configuration	17
8.4. Test Data	17
9. Secondary Radiated Emissions Test	18
9.1. Test Limit	18
9.2. Test Setup	18
9.3. Test Configuration	18
9.4. Test Data	18
10. 3dB Beam Bandwidth Test	19
10.1. Test Limit	19
10.2. Test Equipment	19
10.3. Test Setup	20
10.4. Test Data	20
11. Carrier Sensing Function 1	21
11.1. Test Limit	21
11.2. Test Setup	21
11.3. Test Configuration	21
11.4. Test Data	21
APPENDIX I -- TEST SETUP PHOTOGRAPH	22
APPENDIX II -- EXTERNAL PHOTOGRAPH	22
APPENDIX III -- INTERNAL PHOTOGRAPH	22



TEST REPORT

Applicant : Anker Japan Co., Ltd.
Manufacturer : Anker Innovations Limited
Product Name : eufy Baby Monitor C10
Model No. : T6310
Trade Mark : eufy
Rating(s) : Input: 5V= 1A

Test Standard(s) : MIC Notice No.88 Appendix No.43
Article 2, paragraph 1, item 19

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the MIC Notice No.88 Appendix No.43 and Certificate regulation article 2, paragraph 1, item 19 requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of Receipt

2025-09-02

Date of Test

2025-09-02 to 2025-10-28

Prepared By

Lene Chen

(Lene Chen)

Approved & Authorized Signer

Hugo Chen

(Hugo Chen)



Revision History

Report Version	Description	Issued Date
R00	Original Issue.	2025-10-30



1. General Information

1.1. Client Information

Applicant	:	Anker Japan Co., Ltd.
Address	:	9F Waterras Tower, 2-101, Kanda-Awajicho, Chiyoda-ku, Tokyo
Manufacturer	:	Anker Innovations Limited
Address	:	Unit 56, 8th Floor, Tower 2, Admiralty Centre, 18 Harcourt Road, Hong Kong

1.2. Description of Device (EUT)

Product Name	:	eufy Baby Monitor C10
Model No.	:	T6310
Trade Mark	:	eufy
Test Power Supply	:	DC 5V from adapter input AC 100V/50Hz
Test Sample No.	:	1-2-2(Engineering Sample)
Hardware Version	:	V2
Software Version	:	V1.0.3.8
Adapter	:	Manufacturer: SHENZHEN TEKA TECHNOLOGY CO.,LTD. MODEL: TEKA-UCA10UN INPUT: 100-240V~ 50/60Hz 0.2A MAX OUTPUT: 5.0V= 1.0A

RF Specification

Operation Mode	:	☒ 802.11b	☒ 802.11g	☒ 802.11n(HT20)
		☐ 802.11n(HT40)	☒ 802.11ax(HEW20)	☐ 802.11ax(HEW40)
Operation Frequency	:	2412~2472MHz		
Number of Channel	:	13 Channel for 20MHz bandwidth (2412~2472MHz)		
Modulation Type	:	☒ 802.11b: DSSS (CCK, DQPSK, DBPSK) ☒ 802.11g: OFDM (BPSK, QPSK, 16QAM, 64QAM) ☒ 802.11n: OFDM (BPSK, QPSK, 16QAM, 64QAM) ☒ 802.11ax: OFDMA (BPSK, QPSK, 16QAM, 64QAM, 256QAM)		
Antenna Type	:	ANT1: FPC Antenna ANT2: PCB Antenna		
Antenna Gain(Peak)	:	ANT1: 4.53dBi ANT2: 1.21dBi		
Rated output Power	:	802.11b: 10mW/MHz Max.		



	802.11g:	10mW/MHz Max.
	802.11n(HT20):	10mW/MHz Max.
	802.11ax(HEW20):	10mW/MHz Max.
Remark: (1) All of the RF specification are provided by customer. (2) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual. (3) This product consists of two antennas, an FPC Antenna and a PCB Antenna. These two antennas have the same feed point. For the conducted test, both antenna ports are tested for power. For items other than power, only the worst port (FPC Antenna) is shown. For the radiated test, only the port(FPC Antenna) is needed to be tested. FPC Antenna and PCB Antenna do not support simultaneous transmission.		

1.3. Auxiliary Equipment Used During Test

Title	Manufacturer	Model No.	Serial No.
/	/	/	/

1.4. Description of Test Configuration

The EUT has been tested under typical operating condition. The Applicant provides software to control the EUT for staying in continuous transmitting and receiving mode for testing.

Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)
01	2412	05	2432	09	2452	13	2472
02	2417	06	2437	10	2457		
03	2422	07	2442	11	2462		
04	2427	08	2447	12	2467		

Note:

- For 802.11b, 802.11g, 802.11n(HT20) and 802.11ax(HEW20) modes were test with channel 1, 7, 13.
- 802.11ax mode only support full resource unit size.

1.5. Test Conditions

	Normal Test Conditions
Temperature	26°C
Relative Humidity	52%
Pressure Range	101kPa



1.6. Test Voltage

Power Supply Voltage Fluctuation Test

Voltage Fluctuation Test	Normal Voltage	High Voltage +10% of Normal Voltage	Low Voltage -10% of Normal Voltage
Input To EUT	DC 5V	DC 5.5V	DC 4.5V
Output To RF Module	DC 3.30V	DC 3.30V	DC 3.30V
Voltage Variation (%)	--	0.00%	0.00%

Note: Voltage Variation (%)=(Output high or Low Voltage - Output Normal Voltage)/ Output Normal Voltage* 100

For extreme voltage test, we have tested the relationship between the external power supply and RF IC power supply. Base on the test results, only the normal voltage was selected to perform all items.

1.7. Test Equipment List

For the conducted test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date
1	Spectrum Analyzer	Rohde & Schwarz	FSV40-N	102150	2025-04-25	2026-04-24
2	MXA Spectrum Analysis	KEYSIGHT	N9020A	MY50531823	2024-09-09	2025-09-08
					2025-09-05	2026-09-04
3	MXG RF Vector Signal Generator	Agilent	N5182A	MY47420647	2025-01-14	2026-01-13
4	Constant Temperature Humidity Chamber	ZHONGJIAN	ZJ-KHWS8 0B	N/A	2024-10-14	2025-10-13
					2025-10-10	2026-10-09
5	DC Power Supply	IVYTECH	IV3605	1804D360510	2024-09-09	2025-09-08
					2025-09-05	2026-09-04
6	Oscilloscope	Tektronix	MDO3012	C020298	2024-10-10	2025-10-09
					2025-09-05	2026-09-04

Remark:

(a) Calibration conducted by the National Institute of Information and Communications Technology (NICT) in Japan (hereinafter referred to as "NICT") or a designated calibration agency under Article 102-18 paragraph (1) in JRL.

(b) Correction conducted pursuant to the provisions of Article 135 or Article 144 of the Measurement Act (Act No. 51 of 1992).

(c) Calibration conducted in countries except Japan, which shall be equivalent to the calibration conducted by the NICT or a designated calibration agency under Article 102-18 paragraph (1).

(d) Calibration, etc., conducted by using measuring instruments and other equipment listed in the right column of appended table No. 3, which shall have been given any type of calibration, etc. listed above from (a) to (c)

From JRL Article 24 .2, paragraph 4, Item 2



For the radiated test

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.Due Date
1	EMI Test Receiver(RE2/3#)	Rohde & Schwarz	ESR26	101481	2025-01-14	2026-01-13
2	Double Ridged Horn Antenna	SCHWARZBECK	BBHA 9120D	02555	2022-10-16	2025-10-15
					2025-09-05	2028-09-04

Remark:

(a) Calibration conducted by the National Institute of Information and Communications Technology (NICT) in Japan (hereinafter referred to as "NICT") or a designated calibration agency under Article 102-18 paragraph (1) in JRL.

(b) Correction conducted pursuant to the provisions of Article 135 or Article 144 of the Measurement Act (Act No. 51 of 1992).

(c) Calibration conducted in countries except Japan, which shall be equivalent to the calibration conducted by the NICT or a designated calibration agency under Article 102-18 paragraph (1).

(d) Calibration, etc., conducted by using measuring instruments and other equipment listed in the right column of appended table No. 3, which shall have been given any type of calibration, etc. listed above from (a) to (c)

From JRL Article 24 .2, paragraph 4, Item 2



1.8. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 279531

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 279531.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

Sogood Industrial Zone Laboratory & 1/F. of Building D, Sogood Science and Technology Park, Sanwei Community, Hangcheng Subdistrict, Bao'an District, Shenzhen, Guangdong, China.

1.9. Disclaimer

1. The test report is invalid if not marked with the signatures of the persons responsible for preparing and approving the test report.
2. The test report is invalid if there is any evidence and/or falsification.
3. The results documented in this report apply only to the tested sample, under the conditions and modes of operation as described herein.
4. This document may not be altered or revised in any way unless done so by Anbotek and all revisions are duly noted in the revisions section.
5. Content of the test report, in part or in full, cannot be used for publicity and/or promotional purposes without prior written approval from the laboratory.
6. The authenticity of the information provided by the customer is the responsibility of the customer and the laboratory is not responsible for its authenticity.
7. The data in this report will be synchronized with the corresponding national market supervision and management departments and cross-border e-commerce platforms as required by regulatory agencies.

The laboratory is only responsible for the data released by the laboratory, except for the part provided by the applicant.

1.10. Measurement Uncertainty

Parameter	Uncertainty
Occupied Bandwidth	925Hz
Conducted Output Power	0.76dB
Conducted Spurious Emission	1.24dB
Frequency tolerance	74.60Hz
The measurement uncertainty and decision risk evaluated according to AB/WI-RF-F-032. This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.	



2. Summary of Test Results

Test Standard	Description of Test	Result
MIC Notice No.88 Appendix No.43 Article 2 Paragraph 1 Item 19	Frequency Tolerance	Complies
	Antenna power	Complies
	EIRP	Complies*
	Antenna Power Tolerance	Complies
	Occupied Bandwidth	Complies
	Spread Bandwidth	N/A
	Spurious Emissions	Complies
	Carrier sensing function 1	Complies**
	Carrier sensing function 2	N/A***
	Interference prevention function	Complies
	Secondary Radiated Emissions	Complies
	Transmission Radiated Angle Width (3dB Beam Bandwidth)	Complies****
	Antenna Absolute Gain	Complies

Note:

(1) N/A is an abbreviation for Not Applicable.

(2) This device have more than 1 subcarrier in 1MHz, compliance with the requirement.

*: Application to Antenna Gain more than 2.14dBi.

**: Application to transmitting devices which EIRP is less than (2.14dBi + antenna power limit) and the shortage of EIRP is compensated by the antenna power. Not applicable to this product.

***: Application to transmitting devices with OFDM modulation and the occupied bandwidth greater than 26MHz.

****: Application to EIRP more than 12.14dBm/MHz.

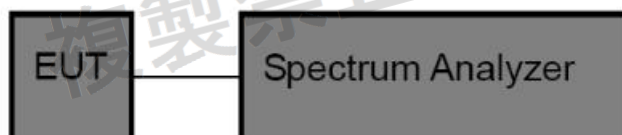


3. Frequency Tolerance Test

3.1. Test Limit

Test Limit	±50 ppm
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3.2. Test Setup



3.3. Test Procedure

Test Frequency= test channel

RBW=VBW=10kHz

Span=1MHz

Sweep time=Auto

Detector mode=Positive peak

Indication mode=Max hold

3.4. Test Data

PASS

Please refer to Appendix A of the Appendix Test Data.



4. Antenna Power Test

4.1. Test Limit

No.	Modulation Method	Frequency Range	Antenna Power	E.I.R.P
1.	FHSS(Compound method with DSSS or OFDM) (OBW within 83.5MHz)	2427-2470.75 MHz	3mW/MHz or less	6.91-16.91dBm/MHz
		2400-2483.5 MHz (except 2427-2470.75MHz)	10mW/MHz or less	12.14-22.14dBm/MHz
2.	DSSS (OBW within 26MHz)	2400 - 2483.5 MHz	10mW/MHz or less	12.14-22.14dBm/MHz
3.	OFDM (OBW within 26MHz)		10mW/MHz or less	12.14- - 22.14dBm/MHz
4.	OFDM (OBW 26-40MHz)		5mW/MHz or less	9.13-19.13dBm/MHz
5.	Other Digital methods (OBW within 26MHz)		10mW or less	12.14-22.14dBm
6.	Tolerance	+20%		

4.2. Test Setup



4.3. Test Configuration

1. Search Frequency of Peak Power

Test Frequency: test channel,

RBW=VBW=1MHz, Span=40MHz for 20MHz bandwidth, Span=80MHz for 40MHz bandwidth, Sweep time=Auto, Detector mode =Positive peak

2. Measure of average burst power

Test Frequency: frequency of peak power

RBW=VBW=1MHz, Span=0Hz, Sweep time=Auto, Detector mode=RMS

3. Antenna power= average burst power

4.4. Test Data

Pass

Please refer to Appendix B of the Appendix Test Data.



5. Occupied Bandwidth (99%) Test

5.1. Test Limit

Modulation type	Limit
FH:	83.5MHz or less
FH + DS:	83.5MHz or less
FH + OFDM:	83.5MHz or less
OFDM:	With 20M Bandwidth: 26MHz or less With 40M Bandwidth: 26-40MHz
Others:	26MHz or less

5.2. Test Setup



5.3. Test Procedure

Test Frequency= test channel

RBW=VBW=300kHz

Span=40MHz

Sweep time=Auto

Detector mode=Positive peak

Indication mode=Max hold

5.4. Test Data

PASS

Please refer to Appendix C of the Appendix Test Data.



6. Spurious Emissions Intensity Test

6.1. Test Limit

Frequency Range	Test Limit
$\leq 2387\text{MHz}$	$\leq 2.5\mu\text{W/MHz}$ (-26dBm/MHz)
2387MHz to 2400MHz	$\leq 25\mu\text{W/MHz}$ (-16dBm/MHz)
2483.5MHz to 2496.5MHz	$\leq 25\mu\text{W/MHz}$ (-16dBm/MHz)
$\geq 2496.5\text{MHz}$	$\leq 2.5\mu\text{W/MHz}$ (-26dBm/MHz)

6.2. Test Setup



6.3. Test Procedure

Step 1:

Test Frequency: test channel,

RBW=VBW=1MHz, Sweep time=Auto, Detector mode=Positive peak

Step 2:

Test Frequency: spurious frequency

RBW=VBW=1MHz, Sweep time=Auto, Detector mode=Sample, Span=0Hz

6.4. Test Data

Pass

Please refer to Appendix D of the Appendix Test Data.

Note: SA set to from 2.4965GHz to 13GHz, plot shows from 2.497GHz to 13GHz as of SA's default format.

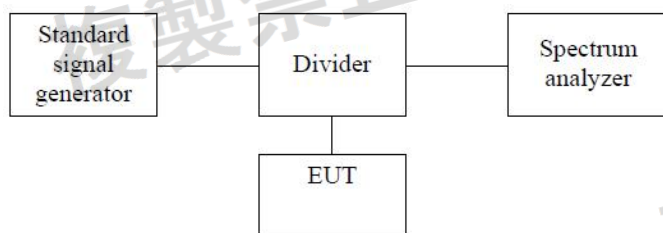


7. Carrier Sensing Function 2

7.1. Test Limit

Test Limit	EUT doesn't transmit when the radio wave of 100mV/m is coming to EUT.
------------	---

7.2. Test Setup



7.3. Test Configuration

1. SSG adjusted the frequency as same as the EUT transmitted signal and emitted the absence of modulation from SSG and power level is $(On\ 22.79+Gr-20*\log(f)[dBm])$ (Gr: dBi; f: MHz). Then turn off the RF signal of SSG.
2. EUT have transmitted the maximum modulation signal and fixed channelize.
3. Setting of SA is following as: RB:1MHz / VB:1MHz / SPAN: 50MHz / AT: 10dB / Ref: 0dBm / Sweep time: Auto / Sweep Mode: Continuous sweep / Detect mode: Positive peak.
4. SSG RF Signal On.
5. EUT shall be stop the transmitted any signal and SSG RF Signal Off. Then EUT will be continuous transmitted signal.

7.4. Test Data

Not applicable. This test only for OFDM modulation and occupied bandwidth greater than 26MHz.

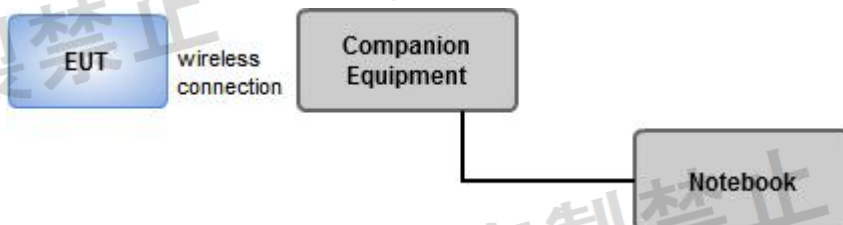


8. Interference Prevention Function

8.1. Test Limit

Test Limit	The identification code shall be 48 bits long.
------------	--

8.2. Test Setup



8.3. Test Configuration

1. Set EUT under operating mode and link up with companion equipment
2. Check communication status between EUT and companion equipment is normal
3. Record the max. reading.
4. Confirm the MAC address of EUT

8.4. Test Data

Test Mode	ID Code	Test Results
WiFi 2.4G	87:85:B8:E0:45:20	Complies



9. Secondary Radiated Emissions Test

9.1. Test Limit

Frequency Range	Test Limit
30~ 1000MHz	$\leq 4.0\text{nW}$ (-54dBm)
1000~ 12500MHz	$\leq 20\text{nW}$ (-47dBm)

9.2. Test Setup



9.3. Test Configuration

Test Frequency: test channel,

Below 1GHz, RBW=VBW=100kHz;

Above 1GHz, RBW=VBW=1MHz,

Sweep time=Auto, Detector mode=Positive peak

Adjust the spectrum analyzer configuration during final testing: Set the spectrum analyzer at the secondary launch measurement as follows. Center frequency secondary firing frequency Sweep frequency width span = 0Hz. If the resolution bandwidth is less than 1 GHz, it is 100 kHz and 1 MHz for 1 GHz or more Same as video bandwidth resolution bandwidth Minimum time guaranteed sweep time measurement accuracy Sweep mode single sweep Detection mode samples or RMS Any emissions identified during the sweeps exceeds 1/10 of applicable limit, shall be individually measured using RMS detector and compared to the limits

9.4. Test Data

Pass

Please refer to Appendix E of the Appendix Test Data.



10. 3dB Beam Bandwidth Test

10.1. Test Limit

Test Limit	Allowable main lobe width (θ_0) = $360/A$ $A = \{ \text{EIRP Power [dBm/MHz]} - 12.14 \text{ [dBm/MHz]} \text{ for DS, OFDM} \}$ or $\{ \text{E.I.R.P Power [dBm/MHz]} - 6.91 \text{ [dBm/MHz]} \text{ for FH} \}$
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10.2. Test Equipment

Step 1

Adjust at the maximum received power point, turning the test equipment horizontally and vertically.

Step 2

Change the height of the measurement antenna from the ground by $\pm 50\text{cm}$ with a central focus on the antenna of test equipment, and search the location that the power is maximum by adjusting the direction of measurement antenna. Set the indicator of spectrum analyzer at this point as "E".

Step 3

By using EIRP (P_E) that is measured at section 4, calculate allowed main beam angle (θ_0) between the horizontal plane and vertical plane of the test equipment as follows.

Allowed main beam angle (θ_0) = $360/A$

θ_0 : Allowed transmitter antenna beamwidth angle in degree of test equipment

P_E : EIRP of test equipment (dBm)

A: A is defined as EIRP divides by the summation of antenna gain 2.14dBi transmitter antenna and average power limit 10mW (In case of using ODFM, or DS, or FHSS, or DS and complex with FHSS, or OFDM and complex with FHSS, 10mW/MHz. However, in FHSS or DS and complex with FHSS, or OFDM and complex with FHSS, when using the frequency from 2,427MHz to 2,470.75MHz, 3mW/MHz) antenna power. In case the value is lower than 1, set A as 1.

Step 4

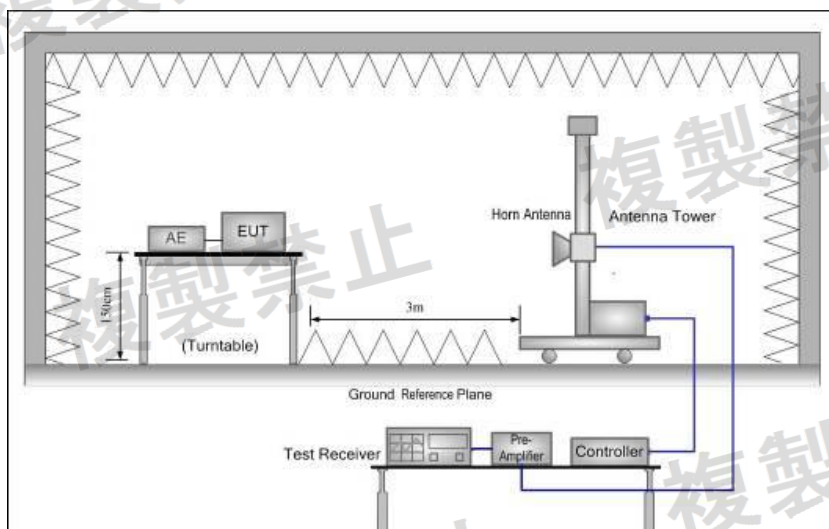
Turn the test equipment in horizontal direction, from main beam direction with the beam angle except main beam angle (θ_0) calculated by (step 3), over all surroundings as much as possible. Confirm that received power is decreased more than 3dB from the maximum point value of received power (E).

Step 5

Return the test equipment to position (step 4), incline the test equipment in vertical direction, from main beam direction with the beam angle except main beam angle (θ_0) calculated by (step 3), Confirm that received power is 3dB lower than the maximum point value of received power (E).



10.3. Test Setup



10.4. Test Data

Pass

Mode	Frequency (MHz)	A	Limit (θ_0 (°))	A1 (°)	A2 (°)	3dB beam bandwidth (°)
802.11 g	2412	1.70	211.98	146	267	121.00
	2442	1.63	220.95	164	250	86.00
	2472	1.69	212.96	166	252	86.00

Note:

- 1) $\theta_0 = 360/A$
- 2) $A = \text{EIRP}/(12.14\text{dBm/MHz, } 802.11 \text{ b/g/n(HT20)})$
- 3) A1, A2: Angle of table, at which point the level is 3dB below the "E";
3dB beam bandwidth = $|A2-A1|$
- 4) Only the worst case is recorded in the report, The direction of the receiving antenna is horizontal.

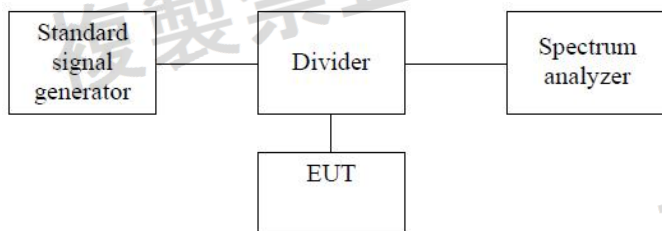


11. Carrier Sensing Function 1

11.1. Test Limit

Test Limit	EUT doesn't transmit when the radio wave of 100mV/m is coming to EUT.
------------	---

11.2. Test Setup



11.3. Test Configuration

1. SSG adjusted the frequency as same as the EUT transmitted signal and emitted the absence of modulation from SSG and power level is $(On\ 22.79 + Gr - 20 \cdot \log(f)) [dBm]$ (Gr: dBi; f: MHz). Then turn off the RF signal of SSG.
2. EUT have transmitted the maximum modulation signal and fixed channelize.
3. Setting of SA is following as: RB:1MHz / VB:1MHz / SPAN: 50MHz / AT: 10dB / Ref: 0dBm / Sweep time: Auto / Sweep Mode: Continuous sweep / Detect mode: Positive peak.
4. SSG RF Signal On.
5. EUT shall be stop the transmitted any signal and SSG RF Signal Off. Then EUT will be continuous transmitted signal.

11.4. Test Data

Type	Test channel	Result
802.11b	CH _L , CH _M , CH _H	Acceptance
802.11g	CH _L , CH _M , CH _H	Acceptance
802.11n(HT20)	CH _L , CH _M , CH _H	Acceptance
802.11ax(HEW20)	CH _L , CH _M , CH _H	Acceptance



APPENDIX I -- TEST SETUP PHOTOGRAPH

Please refer to separated files Appendix I -- Test Setup Photograph_RF

APPENDIX II -- EXTERNAL PHOTOGRAPH

Please refer to separated files Appendix II -- External Photograph

APPENDIX III -- INTERNAL PHOTOGRAPH

Please refer to separated files Appendix III -- Internal Photograph

----- End of Report -----

